



Form PTO 1449
(Modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.
219585US2

SERIAL NO.
10/073,344

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Yuji ABURAKAWA, et al.

FILING DATE
February 13, 2002

GROUP
2633

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
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OCT 07 2003

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

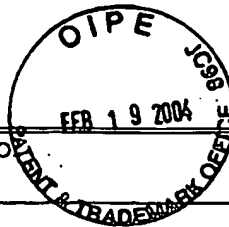
Q221	AW	Y. E. YENICE, et al., SPIE, vol. 3266, XP-009013880, pages 221-230, "ADAPTIVE BEAM-SIZE CONTROL FOR GROUND TO SATELLITE LASER COMMUNICATIONS", January 27-28, 1998
↓	AX	S. ARNON, et al., Applied Optics, vol. 36, no. 24, XP-001153709, pages 6095-6101, "BEAM WIDTH AND TRANSMITTER POWER ADAPTIVE TO TRACKING SYSTEM PERFORMANCE FOR FREE-SPACE OPTICAL COMMUNICATION", August 20, 1997
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

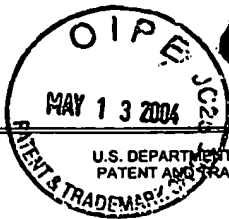
Date Considered 5/17/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 219585US8		SERIAL NO. 10/073,344	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yuji ABURAKAWA, et al.			
				FILING DATE February 13, 2002		GROUP 2633	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
QZW	AA	6,239,888	05/29/2001	H. WILLEBRAND			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
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	AI						
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	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
QZW	AO	WO 98/32250	07/23/1998	WIPO			
I	AP	WO 00/04660	01/27/2000	WIPO			
	AQ	0 859 478	08/19/1998	EUROPE			
V	AR	WO 00/25455	05/04/2000	WIPO			
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Quanghan Wu</i>					Date Considered <i>5/17/05</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

219585US90

SERIAL NO.

10/073,344

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yuji ABURAKAWA, et al.

FILING DATE

February 13, 2002

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2633

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
Q2W ↓	AA	6,049,593	04/11/2000	A. ACAMPORA			
	AB	5,844,705	12/01/1998	C. L. RUTLEDGE			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
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	AK						
	AL						
	AM						
	AN						

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MAY 14 2004

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	1190828	08/19/1998	THE PEOPLE'S REPUBLIC OF CHINA (with corr. US 5,844,705)		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

5/17/05

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